 ch No	

Application No.	Applicant(s)	
09/122,349	HACKING ET AL.	
Examiner	Art Unit	
Denise Tran	2186	

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SEARCHED			
Class	Subclass	Date	Examiner
711	133- 135,109, 141- 145,156, 133,	1/13/2005	DT
	214-215;		DT
712	225-226	1/20/2005	DT
711	159	1/20/2005	DT
	217-219	1/21/2005	DT
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INI	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
711	214; 135;	1/21/2005	DT	
	144-145;		DT	
	133; 159	1/21/2005	DT	
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
East (USPGPUB;USPAT;USOCR;EPO; JPO;DERWENT;IBM-TDB)	1/13/2005	DT
East (USPGPUB;USPAT;USOCR;EPO; JPO;DERWENT;IBM-TDB)	1/14/2005	DT
East (USPGPUB;USPAT;USOCR;EPO; JPO;DERWENT;IBM-TDB)	1/20/2005	DT
Consulting with Hery Tsai Primary Patent examiner 2183 search 712/ 225-226	1/14/2005	DT
Stic search (Web; JPIO; WPIX)	1/14/2005	DΥ
Inventor Names search (East, Palm, Stic)	1/20/2005	DT
East (USPGPUB;USPAT;USOCR;EPO; JPO;DERWENT;IBM-TDB)	1/21/2005	DT